







SN54AHC573, SN74AHC573

SCLS242M - OCTOBER 1995 - REVISED AUGUST 2024

SNx4AHC573 Octal Transparent D-Type Latches With 3-State Outputs

1 Features

- Operating range 2V to 5.5V V_{CC}
- 3-state outputs directly drive bus lines
- Latch-up performance exceeds 250mA per JESD
- On products compliant to MIL-PRF-38535, all parameters are tested unless otherwise noted. On all other products, production processing does not necessarily include testing of all parameters.

2 Applications

- Servers
- PCs and Notebooks
- **Network Switches**
- Wearable Health and Fitness Devices
- Telecom Infrastructures
- Electronic Points of Sale

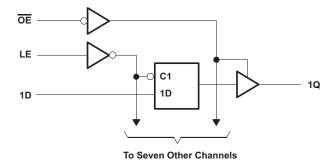
3 Description

The SNx4AHC573 devices are octal transparent Dtype latches designed for 2V to 5.5V V_{CC} operation.

Device Information

PART NUMBER	PACKAGE ⁽¹⁾	PACKAGE SIZE(2)	BODY SIZE(3)
	DB (SSOP, 20)	7.50mm × 7.8mm	7.50mm x 5.30mm
	DGV (TVSOP, 20)	5.00mm x 6.4mm	5.00mm x 4.40mm
SNx4AHC573	DW (SOIC, 20)	12.80mm × 10.3mm	12.8mm x 7.5mm
	N (PDIP, 20)	25.40mm x 9.4mm	25.40mm x 6.35mm
	NS (SOP, 20)	12.6mm × 7.8mm	12.6mm × 5.3mm
	PW (TSSOP, 20)	6.50mm × 6.4mm	6.50mm × 4.40mm

- For more information, see Section 11.
- The package size (length × width) is a nominal value and includes pins, where applicable.
- The body size (length × width) is a nominal value and does not include pins.



Simplified Schematic



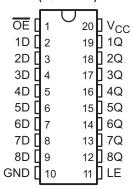
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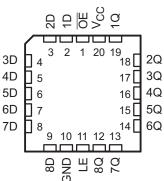


4 Pin Configuration and Functions

SN54AHC573 . . . J OR W PACKAGE SN74AHC573 . . . DB, DGV, DW, N, NS, OR PW PACKAGE (TOP VIEW)







	PIN	I/O	DESCRIPTION
NO.	NAME	- 1/O	DESCRIPTION
1	ŌĒ	I	Output Enable
2	1D	I	1D Input
3	2D	I	2D Input
4	3D	I	3D Input
5	4D	I	4D Input
6	5D	I	5D Input
7	6D	I	6D Input
8	7D	I	7D Input
9	8D	I	8D Input
10	GND	_	Ground
11	LE	I	Latch Enable
12	8Q	0	8Q Output
13	7Q	0	7Q Output
14	6Q	0	6Q Output
15	5Q	0	5Q Output
16	4Q	0	4Q Output
17	3Q	0	3Q Output
18	2Q	0	2Q Output
19	1Q	0	1Q Output
20	V _{CC}	_	Power Pin



5 Specifications

5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted) (1)

			MIN	MAX	UNIT
V _{CC}	Supply voltage range		-0.5	7	V
VI	Input voltage range ⁽²⁾		-0.5	7	V
Vo	Output voltage range ⁽²⁾		-0.5	V _{CC} + 0.5	V
I _{IK}	Input clamp current	V ₁ < 0		-20	mA
I _{OK}	Output clamp current	$V_O < 0$ or $V_O > V_{CC}$		±20	mA
Io	Continuous output current	V _O = 0 to V _{CC}		±25	mA
	Continuous current through V _{CC} or GND			±75	mA
T _{stg}	Storage temperature range		-65	150	°C

⁽¹⁾ Stresses beyond those listed under Absolute Maximum Ratings may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under Recommended Operating Conditions is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

5.2 ESD Ratings

			Value	UNIT
		Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins ⁽¹⁾	±2000	
V _(ESD)	Electrostatic discharge	Charged device model (CDM), per JEDEC specification JESD22-C101, all pins ⁽²⁾	±1000	V

Product Folder Links: SN54AHC573 SN74AHC573

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²⁾ The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

⁽¹⁾ JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

⁽²⁾ JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.



5.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)(1)

			SN54AH	C573	SN74AH	C573	LINUT
			MIN	MAX	MIN	MAX	UNIT
V _{CC}	Supply voltage		2	5.5	2	5.5	V
		V _{CC} = 2 V	1.5		1.5		
V_{IH}	High-level input voltage	V _{CC} = 3 V	2.1		2.1		V
		V _{CC} = 5.5 V	3.85		3.85		
		V _{CC} = 2 V		0.5		0.5	
V_{IL}	Low-level input voltage	V _{CC} = 3 V		0.9		0.9	V
		V _{CC} = 5.5 V		1.65		1.65	
Vı	Input voltage		0	5.5	0	5.5	V
Vo	Output voltage		0	V _{CC}	0	V _{CC}	V
		V _{CC} = 2 V		-50		-50	μΑ
I _{OH}	High-level output current	$V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$		-4		-4	mA
		V _{CC} = 5 V ± 0.5 V		-8		-8	ША
		V _{CC} = 2 V		50		50	μΑ
I_{OL}	Low-level output current	$V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$		4		4	m Λ
		$V_{CC} = 5 V \pm 0.5 V$		8		8	mA
Δt/Δν	Input transition rise or fall rate	$V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$		100		100	ns/V
ΔΨΔV	Input transition rise or fall rate	$V_{CC} = 5 V \pm 0.5 V$		20		20	iis/v
T _A	Operating free-air temperature		-55	125	-40	125	°C

⁽¹⁾ All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs (SCBA004).

5.4 Thermal Information

				SN74AH	C573			
	THERMAL METRIC ⁽¹⁾	DW	DB	DGV	N	NS	PW	UNIT
				20 PII	NS			
$R_{\theta JA}$	Junction-to-ambient thermal resistance	81.1	97.9	117.2	53.3	77.6	116.8	
R _{0JC(top)}	Junction-to-case (top) thermal resistance	48.9	59.6	32.7	40.0	42.7	58.5	
$R_{\theta JB}$	Junction-to-board thermal resistance	53.8	53.1	58.7	34.2	45.7	78.7	°C/W
ΨЈТ	Junction-to-top characterization parameter	19.5	21.3	1.15	26.4	10.2	12.6	- C/VV
ΨЈВ	Junction-to-board characterization parameter	53.1	52.7	58.0	34.1	45.2	77.9	
R _{0JC(bot)}	Junction-to-case (bottom) thermal resistance	N/A	N/A	N/A	N/A	N/A	N/A	

(1) For more information about traditional and new thermal metrics, see the IC Package Thermal Metrics application report (SPRA953).

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5.5 Electrical Characteristics

over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	V _{cc}		A = 25°		SN54Al	-	SN74Al	HC573	-40°C to 125°C SN74AHC573		UNIT
			MIN	TYP	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
		2 V	1.9	2		1.9		1.9		1.9		
	I _{OH} = -50 μA	3 V	2.9	3		2.9		2.9		2.9		V
V _{OH}		4.5 V	4.4	4.5		4.4		4.4		4.4		v
	I _{OH} = -4 mA	3 V	2.58			2.48		2.48		2.48		
	I _{OH} = -8 mA	4.5 V	3.94			3.8		3.8		3.8		
		2 V			0.1		0.1		0.1		0.1	
	I _{OL} = 50 μA	3 V			0.1		0.1		0.1		0.1	V
V _{OL}		4.5 V			0.1		0.1		0.1		0.1	v
	I _{OL} = 4 mA	3 V			0.36		0.5		0.44		0.44	
	I _{OL} = 8 mA	4.5 V			0.36		0.5		0.44		0.44	
I _I	V _I = 5.5 V or GND	0 V to 5.5 V			±0.1		±1 ⁽¹⁾		±1		±1	μA
l _{oz}	$V_I = V_{IL} \text{ or } V_{IH},$ $V_O = V_{CC} \text{ or GND}$	5.5 V			±0.25		±2.5		±2.5		±2.5	μA
I _{CC}	$V_I = V_{CC}$ or GND, $I_O = 0$	5.5 V			4		40		40		40	μA
C _i	V _I = V _{CC} or GND	5 V		2.5	10				10		10	pF
Co	V _O = V _{CC} or GND	5 V		3.5								pF

⁽¹⁾ On products compliant to MIL-PRF-38535, this parameter is not production tested at $V_{CC} = 0 \text{ V}$.

5.6 Timing Requirements, $V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$

over recommended operating free-air temperature range (unless otherwise noted) (see Load Circuit and Voltage Waveforms)

PARAMETER		T _A = 2	25°C	SN54AF	IC573	SN74AH	C573	T _A = -40°C to SN74AHC5	UNIT	
		MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
t _w	Pulse duration, LE high	5		5		5		5		ns
t _{su}	Setup time, data before LE↓	3.5		3.5		3.5		3.5		ns
t _h	Hold time, data after LE↓	1.5		1.5		1.5		1.5		ns

5.7 Timing Requirements, $V_{CC} = 5 V \pm 0.5 V$

over recommended operating free-air temperature range (unless otherwise noted) (see Load Circuit and Voltage Waveforms)

PARAMETER		T _A = 2	25°C	SN54AHC573		SN74AH	C573	T _A = -40°C to SN74AHC	UNIT	
		MIN	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
t _w	Pulse duration, LE high	5		5		5		5		ns
t _{su}	Setup time, data before LE↓	3.5		3.5		3.5		3.5		ns
t _h	Hold time, data after LE↓	1.5		1.5		1.5		1.5		ns

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5.8 Switching Characteristics, $V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$

over recommended operating free-air temperature range (unless otherwise noted) (see Load Circuit and Voltage Waveforms)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	LOAD CAPACITANCE		A = 25°		SN54AH		SN74A		T _A = -40°C to SN74AHC		UNIT
	(INFOT)	(001701)	CAFACITANCE	MIN	TYP	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
t _{PLH}	D	Q	C ₁ = 15 pF		7 ⁽¹⁾	11 ⁽¹⁾	1 ⁽¹⁾	13 ⁽¹⁾	1	13	1	14	ns
t _{PHL}	U	Q	OL = 15 pr		7 ⁽¹⁾	11 ⁽¹⁾	1 ⁽¹⁾	13 ⁽¹⁾	1	13	1	14	1115
t _{PLH}	LE	Q	C _L = 15 pF		7.6 ⁽¹⁾	11.9 ⁽¹⁾	1 ⁽¹⁾	14 ⁽¹⁾	1	14	1	15	ns
t _{PHL}	LE	Q	OL = 15 pr		7.6 ⁽¹⁾	11.9 ⁽¹⁾	1 ⁽¹⁾	14 ⁽¹⁾	1	14	1	15	1115
t _{PZH}	ŌĒ	Q	C ₁ = 15 pF		7.3 ⁽¹⁾	11.5 ⁽¹⁾	1 ⁽¹⁾	13.5 ⁽¹⁾	1	13.5	1	14.5	ns
t _{PZL}	OE	Q	OL = 15 pr		7.3 ⁽¹⁾	11.5 ⁽¹⁾	1 ⁽¹⁾	13.5 ⁽¹⁾	1	13.5	1	14.5	1115
t _{PHZ}	ŌĒ	Q	C ₁ = 15 pF		8.3 ⁽¹⁾	11 ⁽¹⁾	1 ⁽¹⁾	13 ⁽¹⁾	1	13	1	14	ns
t _{PLZ}	OE	Q	OL = 15 pr		8.3 ⁽¹⁾	11 ⁽¹⁾	1 ⁽¹⁾	13 ⁽¹⁾	1	13	1	14	1115
t _{PLH}	D	Q	C ₁ = 50 pF		9.5	14.5	1	16.5	1	16.5	1	18	ns
t _{PHL}	U	Q	OL = 30 pr		9.5	14.5	1	16.5	1	16.5	1	18	1115
t _{PLH}	LE	Q	C ₁ = 50 pF		10.1	15.4	1	17.5	1	17.5	1	19	ns
t _{PHL}	LE	Q	OL = 30 pr		10.1	15.4	1	17.5	1	17.5	1	19	1115
t _{PZH}	ŌĒ	Q	C _L = 50 pF		9.8	15	1	17	1	17	1	18	ns
t _{PZL}	OE	Q	OL = 50 pr		9.8	15	1	17	1	17	1	18	1115
t _{PHZ}	ŌĒ	Q	C _L = 50 pF		10.7	14.5	1	16.5	1	16.5	1	17.5	ns
t _{PLZ}	OE	ų ų	C _L = 50 pr		10.7	14.5	1	16.5	1	16.5	1	17.5	1 115
t _{sk(o)}			C _L = 50 pF			1.5 ⁽²⁾				1.5			ns

⁽¹⁾ On products compliant to MIL-PRF-38535, this parameter is not production tested.

5.9 Switching Characteristics, $V_{CC} = 5 V \pm 0.5 V$

over recommended operating free-air temperature range (unless otherwise noted) (see Load Circuit and Voltage Waveforms)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	LOAD CAPACITANCE	T _A = 25°C	;	SN54AI	HC573	SN74AH	IC573	T _A = -40°C to SN74AHC		UNIT
	(INFO1)	(OUTFUT)	CAFACITANCE	MIN TYP	MAX	MIN	MAX	MIN	MAX	MIN	MAX	
t _{PLH}	D	Q	C ₁ = 15 pF	4.5 ⁽¹⁾	6.8 ⁽¹⁾	1 ⁽¹⁾	8(1)	1	8	1	8.5	ns
t _{PHL}	U	Q	OL - 15 pr	4.5 ⁽¹⁾	6.8 ⁽¹⁾	1 ⁽¹⁾	8(1)	1	8	1	8.5	115
t _{PLH}	LE	Q	C _L = 15 pF	5 ⁽¹⁾	7.7 ⁽¹⁾	1 ⁽¹⁾	9(1)	1	9	1	10	ns
t _{PHL}	LL	Q	OL = 13 pi	5 ⁽¹⁾	7.7 ⁽¹⁾	1 ⁽¹⁾	9(1)	1	9	1	10	115
t _{PZH}	ŌĒ	Q	C _L = 15 pF	5.2 ⁽¹⁾	7.7 ⁽¹⁾	1 ⁽¹⁾	9(1)	1	9	1	10	ns
t _{PZL}	OL	Q	OL = 13 pi	5.2 ⁽¹⁾	7.7 ⁽¹⁾	1 ⁽¹⁾	9(1)	1	9	1	10	115
t _{PHZ}	ŌĒ	Q	C ₁ = 15 pF	5.2 ⁽¹⁾	7.7 ⁽¹⁾	1 ⁽¹⁾	9(1)	1	9	1	10	ns
t _{PLZ}	OL	Q	OL = 13 pi	5.2 ⁽¹⁾	7.7 ⁽¹⁾	1 ⁽¹⁾	9(1)	1	9	1	10	115
t _{PLH}	D	Q	C ₁ = 50 pF	6	8.8	1	10	1	10	1	11	ns
t _{PHL}	D	Q	о_ – 50 рі	6	8.8	1	10	1	10	1	11	115
t _{PLH}	LE	Q	C ₁ = 50 pF	6.5	9.7	1	11	1	11	1	12	ns
t _{PHL}	LL	Q	о_ – 50 рі	6.5	9.7	1	11	1	11	1	12	115
t _{PZH}	ŌĒ	Q	C ₁ = 50 pF	6.7	9.7	1	11	1	11	1	12	ns
t _{PZL}	OL	Q	O _L = 30 βi	6.7	9.7	1	11	1	11	1	12	113
t _{PHZ}	ŌĒ	Q	C ₁ = 50 pF	6.7	9.7	1	11	1	11	1	12	ns
t _{PLZ}	OL .	Q	OL – 30 bi	6.7	9.7	1	11	1	11	1	12	110
t _{sk(o)}			C _L = 50 pF		1 ⁽²⁾				1			ns

⁽¹⁾ On products compliant to MIL-PRF-38535, this parameter is not production tested.

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⁽²⁾ On products compliant to MIL-PRF-38535, this parameter does not apply.

⁽²⁾ On products compliant to MIL-PRF-38535, this parameter does not apply.



5.10 Noise Characteristics

 $V_{CC} = 5 \text{ V}, C_L = 50 \text{ pF}, T_A = 25^{\circ}\text{C}$ (1)

	PARAMETER	SN74AHC	UNIT	
	FARAMETER	MIN	MAX	UNIT
V _{OL(P)}	Quiet output, maximum dynamic V _{OL}		1	V
V _{OL(V)}	Quiet output, minimum dynamic V _{OL}		-0.8	V
V _{OH(V)}	Quiet output, minimum dynamic V _{OH}	4		V
V _{IH(D)}	High-level dynamic input voltage	3.5		V
V _{IL(D)}	Low-level dynamic input voltage		1.5	V

⁽¹⁾ Characteristics are for surface-mount packages only.

5.11 Operating Characteristics

 V_{CC} = 5 V, T_A = 25°C

	PARAMETER	TEST CO	TEST CONDITIONS				
C _{pd}	Power dissipation capacitance	No load,	f = 1 MHz	16	pF		

5.12 Typical Characteristics

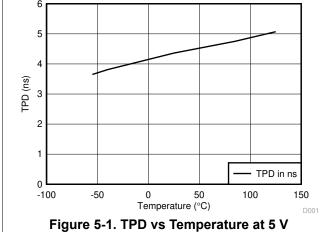
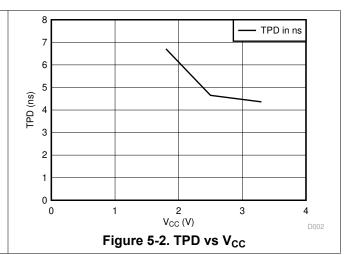
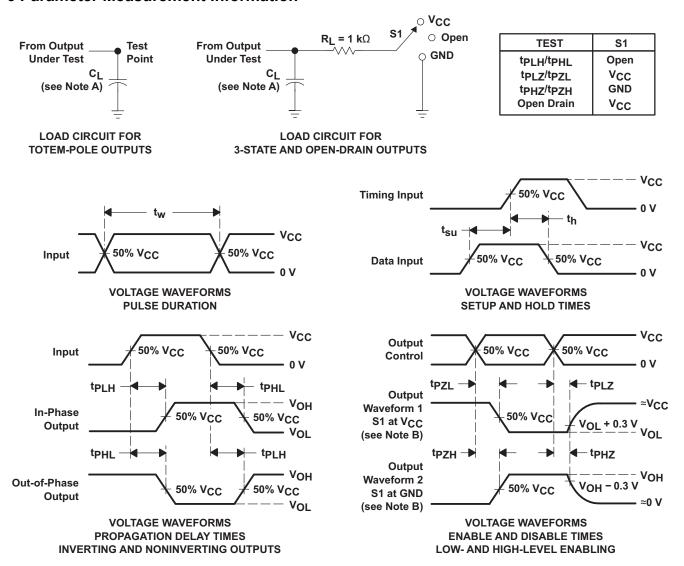


Figure 5-1. TPD vs Temperature at 5 V





6 Parameter Measurement Information



NOTES: A. C_I includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, $Z_O = 50 \ \Omega$, $t_f \leq 3 \ ns$, $t_f \leq 3 \ ns$.
- D. The outputs are measured one at a time with one input transition per measurement.
- E. All parameters and waveforms are not applicable to all devices.

Figure 6-1. Load Circuit and Voltage Waveforms

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7 Detailed Description

7.1 Overview

The SNx4AHC573 devices are octal transparent D-type latches designed for 2-V to 5.5-V V_{CC} operation.

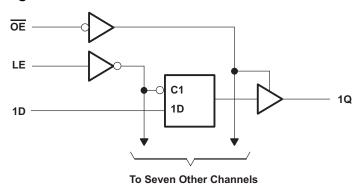
When the latch-enable (LE) input is high, the Q outputs follow the data (D) inputs. When LE is low, the Q outputs are latched at the logic levels of the D inputs.

A buffered output-enable (\overline{OE}) input can be used to place the eight outputs in either a normal logic state (high or low) or the high-impedance state. In the high-impedance state, the outputs neither load nor drive the bus lines significantly. The high-impedance state and increased drive provide the capability to drive bus lines without interface or pull-up components.

OE does not affect the internal operations of the latches. Old data can be retained or new data can be entered while the outputs are in the high-impedance state.

To ensure the high-impedance state during power up or power down, \overline{OE} should be tied to V_{CC} through a pull-up resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

7.2 Functional Block Diagram



7.3 Feature Description

- · Wide operating voltage range
 - Operates from 2 V to 5.5 V
- Allows down voltage translation
 - Inputs accept voltages to 5.5 V
- Slow edges reduce output ringing

7.4 Device Functional Modes

Table 7-1. Function Table (Each Latch)

	INPUTS	OUTPUT	
ŌĒ	LE	D	Q
L	Н	Н	Н
L	Н	L	L
L	L	Χ	Q_0
Н	Χ	Χ	Z

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8 Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

8.1 Application Information

The SN74AHC573 is a low-drive CMOS device that can be used for a multitude of bus-interface type applications where output ringing is a concern. The low drive and slow edge rates will minimize overshoot and undershoot on the outputs. The inputs accept voltages up to 5.5 V allowing down translation to the V_{CC} level. Figure 8-2 shows how the slower edges can reduce ringing on the output compared to higher drive parts like AC.

8.2 Typical Application

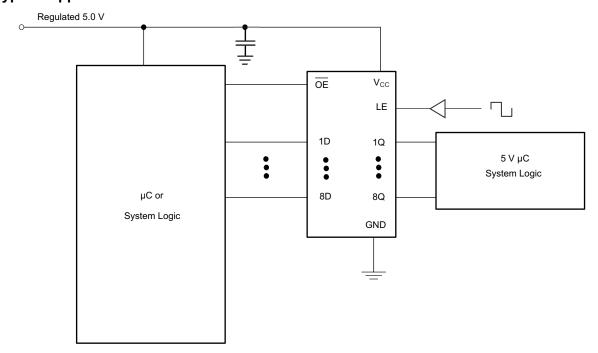


Figure 8-1. Typical Application Schematic

8.2.1 Design Requirements

This device uses CMOS technology and has balanced output drive. Care should be taken to avoid bus contention because it can drive currents that would exceed maximum limits. The high drive will also create fast edges into light loads; therefore, routing and load conditions should be considered to prevent ringing.

8.2.2 Detailed Design Procedure

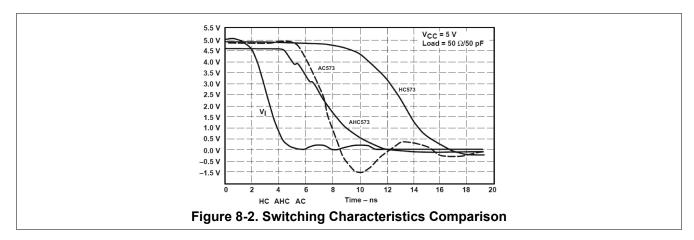
- Recommended input conditions
 - Rise time and fall time specs: See ($\Delta t/\Delta V$) in the Section 5.3 table.
 - Specified High and low levels: See (V_{IH} and V_{IL}) in the Section 5.3 table.
 - Inputs are overvoltage tolerant allowing them to go as high as 5.5 V at any valid V_{CC}.
- 2. Recommend output conditions
 - Load currents should not exceed 25 mA per output and 75 mA total for the part.
 - Outputs should not be pulled above V_{CC}.

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8.2.3 Application Curves



8.3 Power Supply Recommendations

The power supply can be any voltage between the MIN and MAX supply voltage rating located in the Section 5.3 table.

Each V_{CC} pin should have a good bypass capacitor to prevent power disturbance. For devices with a single supply, 0.1 μ F bypass capacitor is recommended. If there are multiple V_{CC} pins, 0.01 μ F or 0.022 μ F is recommended for each power pin. It is acceptable to parallel multiple bypass capacitors to reject different frequencies of noise. A 0.1 μ F and 1 μ F are commonly used in parallel. The bypass capacitor should be installed as close to the power pin as possible for best results.

8.4 Layout

8.4.1 Layout Guidelines

When using multiple bit logic devices inputs should not ever float.

In many cases, functions or parts of functions of digital logic devices are unused, for example, when only two inputs of a triple-input AND gate are used or only 3 of the 4 buffer gates are used. Such input pins should not be left unconnected because the undefined voltages at the outside connections result in undefined operational states. Specified in Figure 8-3 are the rules that must be observed under all circumstances. All unused inputs of digital logic devices must be connected to a high or low bias to prevent them from floating. The logic level that should be applied to any particular unused input depends on the function of the device. Generally they will be tied to GND or V_{CC} ; whichever makes more sense or is more convenient. It is generally acceptable to float outputs unless the part is a transceiver. If the transceiver has an output enable pin, it will disable the outputs section of the part when asserted. This will not disable the input section of the IO's so they cannot float when disabled.

8.4.2 Layout Example

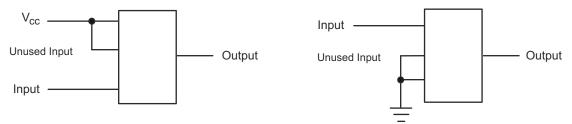


Figure 8-3. Layout Diagram

9 Device and Documentation Support

9.1 Related Links

The table below lists quick access links. Categories include technical documents, support and community resources, tools and software, and quick access to sample or buy.

Table 9-1. Related Links

PARTS	PRODUCT FOLDER	RODUCT FOLDER SAMPLE & BUY		TOOLS & SOFTWARE	SUPPORT & COMMUNITY		
SN54AHC573	Click here	Click here	Click here	Click here	Click here		
SN74AHC573	Click here	Click here	Click here	Click here	Click here		

9.2 Trademarks

All trademarks are the property of their respective owners.

9.3 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

9.4 Glossary

TI Glossary

This glossary lists and explains terms, acronyms, and definitions.

10 Revision History

С	hanges from Revision L (September 2014) to Revision M (August 2024)	Page
•	Added package size to Device information table	1
•	Updated Handling Ratings to ESD Ratings table	4
•	Updated R θ JA values: PW = 103.3 to 116.8, DW = 79.4 to 81.1, NS = 79.2 to 77.6; Updated PW, DW, a NS packages for R θ JC(top), R θ JB, Ψ JT, Ψ JB, and R θ JC(bot), all values in °C/W	

С	hanges from Revision K (January 2004) to Revision L (September 2014)	Page
•	Updated document to new TI data sheet format	1
•	Deleted Ordering Information table	1
•	Added Military Disclaimer to Features list	1
•	Added Applications	
•	Added Handling Ratings table	
•	Changed MAX operating temperature to 125°C in Recommended Operating Conditions table	
•	Added Thermal Information table	<mark>5</mark>
•	Added -40°C to 125°C temperature range for SN74AHC573 in Electrical Characteristics table	6
•	Added T _A = -40°C to 125°C temperature range for SN74AHC573 in Timing Requirements table	6
•	Added T _A = -40°C to 125°C temperature range for SN74AHC573 in Timing Requirements table	6
•	Added $T_A = -40$ °C to 125°C temperature range for SN74AHC573 in Switching Characteristics table	<mark>7</mark>
•	Added $T_A = -40$ °C to 125°C temperature range for SN74AHC573 in Switching Characteristics table	<mark>7</mark>
•	Added Typical Characteristics	8
•	Added Application and Implementation section	11
•	Added Power Supply Recommendations and Layout sections	12
_	····	

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11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

www.ti.com

2-Dec-2024

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
5962-9685601Q2A	ACTIVE	LCCC	FK	20	55	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962- 9685601Q2A SNJ54AHC 573FK	Samples
5962-9685601QRA	ACTIVE	CDIP	J	20	20	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-9685601QR A SNJ54AHC573J	Samples
5962-9685601QSA	ACTIVE	CFP	W	20	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-9685601QS A SNJ54AHC573W	Samples
SN74AHC573DBR	ACTIVE	SSOP	DB	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	HA573	Samples
SN74AHC573DGVR	ACTIVE	TVSOP	DGV	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	HA573	Samples
SN74AHC573DW	OBSOLETE	SOIC	DW	20		TBD	Call TI	Call TI	-40 to 125	AHC573	
SN74AHC573DWR	ACTIVE	SOIC	DW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	AHC573	Samples
SN74AHC573DWRE4	ACTIVE	SOIC	DW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	AHC573	Samples
SN74AHC573DWRG4	ACTIVE	SOIC	DW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	AHC573	Samples
SN74AHC573N	ACTIVE	PDIP	N	20	20	RoHS & Green	NIPDAU	N / A for Pkg Type	-40 to 125	SN74AHC573N	Samples
SN74AHC573NSR	ACTIVE	SOP	NS	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	AHC573	Samples
SN74AHC573PW	OBSOLETE	TSSOP	PW	20		TBD	Call TI	Call TI	-40 to 125	HA573	
SN74AHC573PWR	ACTIVE	TSSOP	PW	20	2000	RoHS & Green	NIPDAU SN	Level-1-260C-UNLIM	-40 to 125	HA573	Samples
SN74AHC573PWRG4	ACTIVE	TSSOP	PW	20	2000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-40 to 125	HA573	Samples
SNJ54AHC573FK	ACTIVE	LCCC	FK	20	55	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962- 9685601Q2A SNJ54AHC 573FK	Samples
SNJ54AHC573J	ACTIVE	CDIP	J	20	20	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-9685601QR A SNJ54AHC573J	Samples



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Orderable Device	Status	Package Type	Package Drawing	Pins	Package Qty	Eco Plan	Lead finish/ Ball material	MSL Peak Temp	Op Temp (°C)	Device Marking (4/5)	Samples
SNJ54AHC573W	ACTIVE	CFP	W	20	25	Non-RoHS & Green	SNPB	N / A for Pkg Type	-55 to 125	5962-9685601QS A SNJ54AHC573W	Samples

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

OTHER QUALIFIED VERSIONS OF SN54AHC573, SN74AHC573:



PACKAGE OPTION ADDENDUM

www.ti.com 2-Dec-2024

• Catalog : SN74AHC573

• Automotive : SN74AHC573-Q1, SN74AHC573-Q1

Military: SN54AHC573

NOTE: Qualified Version Definitions:

Catalog - TI's standard catalog product

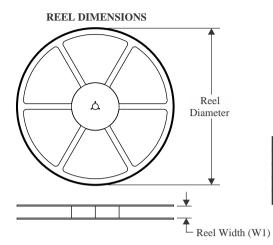
• Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

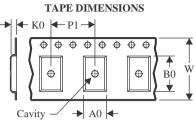
• Military - QML certified for Military and Defense Applications



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TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

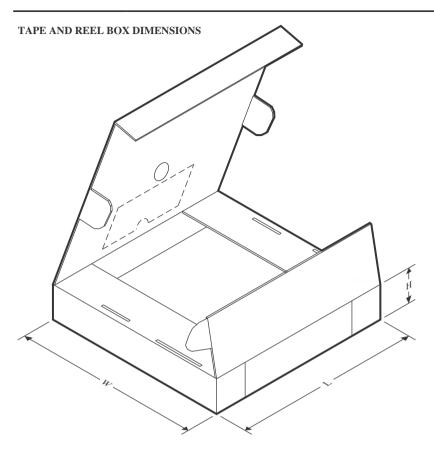


*All dimensions are nominal

Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
SN74AHC573DBR	SSOP	DB	20	2000	330.0	16.4	8.2	7.5	2.5	12.0	16.0	Q1
SN74AHC573DGVR	TVSOP	DGV	20	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1
SN74AHC573DWR	SOIC	DW	20	2000	330.0	24.4	10.9	13.3	2.7	12.0	24.0	Q1
SN74AHC573DWR	SOIC	DW	20	2000	330.0	24.4	10.9	13.3	2.7	12.0	24.0	Q1
SN74AHC573NSR	SOP	NS	20	2000	330.0	24.4	8.4	13.0	2.5	12.0	24.0	Q1
SN74AHC573NSR	SOP	NS	20	2000	330.0	24.4	8.4	13.0	2.5	12.0	24.0	Q1
SN74AHC573PWR	TSSOP	PW	20	2000	330.0	16.4	6.95	7.0	1.4	8.0	16.0	Q1
SN74AHC573PWR	TSSOP	PW	20	2000	330.0	16.4	6.95	7.0	1.4	8.0	16.0	Q1
SN74AHC573PWRG4	TSSOP	PW	20	2000	330.0	16.4	6.95	7.1	1.6	8.0	16.0	Q1



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*All dimensions are nominal

7 til dillionololio ale nominal							
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
SN74AHC573DBR	SSOP	DB	20	2000	356.0	356.0	35.0
SN74AHC573DGVR	TVSOP	DGV	20	2000	356.0	356.0	35.0
SN74AHC573DWR	SOIC	DW	20	2000	367.0	367.0	45.0
SN74AHC573DWR	SOIC	DW	20	2000	356.0	356.0	45.0
SN74AHC573NSR	SOP	NS	20	2000	367.0	367.0	45.0
SN74AHC573NSR	SOP	NS	20	2000	367.0	367.0	45.0
SN74AHC573PWR	TSSOP	PW	20	2000	353.0	353.0	32.0
SN74AHC573PWR	TSSOP	PW	20	2000	356.0	356.0	35.0
SN74AHC573PWRG4	TSSOP	PW	20	2000	356.0	356.0	35.0





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TUBE



*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
5962-9685601Q2A	FK	LCCC	20	55	506.98	12.06	2030	NA
5962-9685601QSA	W	CFP	20	25	506.98	26.16	6220	NA
SN74AHC573N	N	PDIP	20	20	506	13.97	11230	4.32
SNJ54AHC573FK	FK	LCCC	20	55	506.98	12.06	2030	NA
SNJ54AHC573W	W	CFP	20	25	506.98	26.16	6220	NA

N (R-PDIP-T**)

PLASTIC DUAL-IN-LINE PACKAGE

16 PINS SHOWN



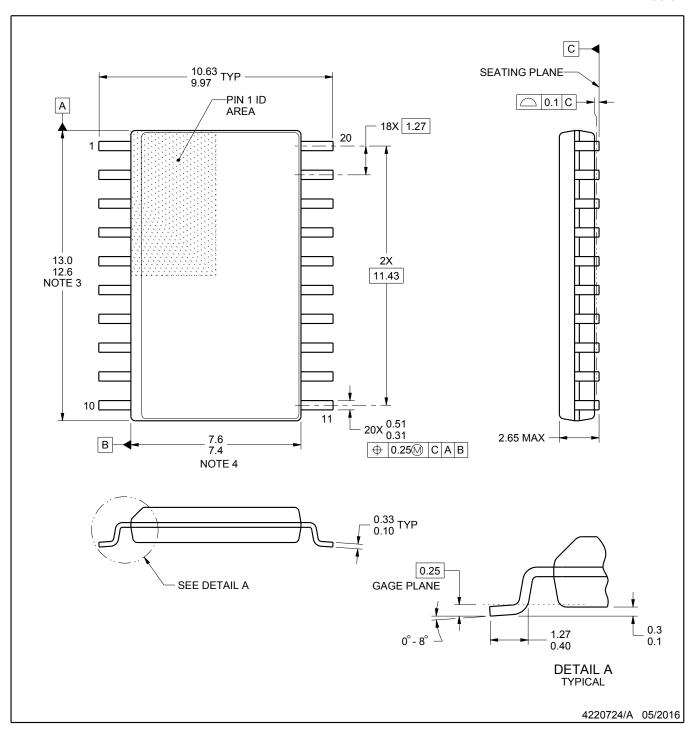
NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- Falls within JEDEC MS-001, except 18 and 20 pin minimum body length (Dim A).
- The 20 pin end lead shoulder width is a vendor option, either half or full width.





SOIC



NOTES:

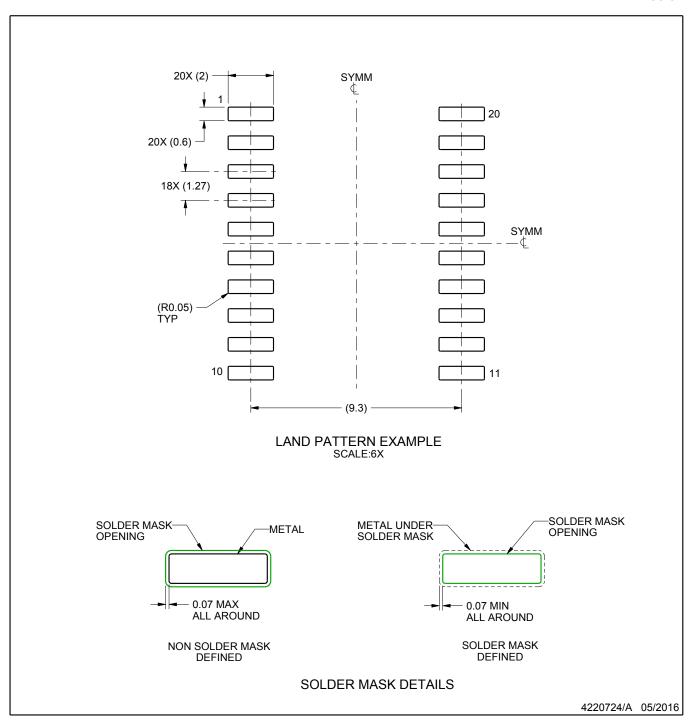
- 1. All linear dimensions are in millimeters. Dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.43 mm per side.
- 5. Reference JEDEC registration MS-013.



SOIC

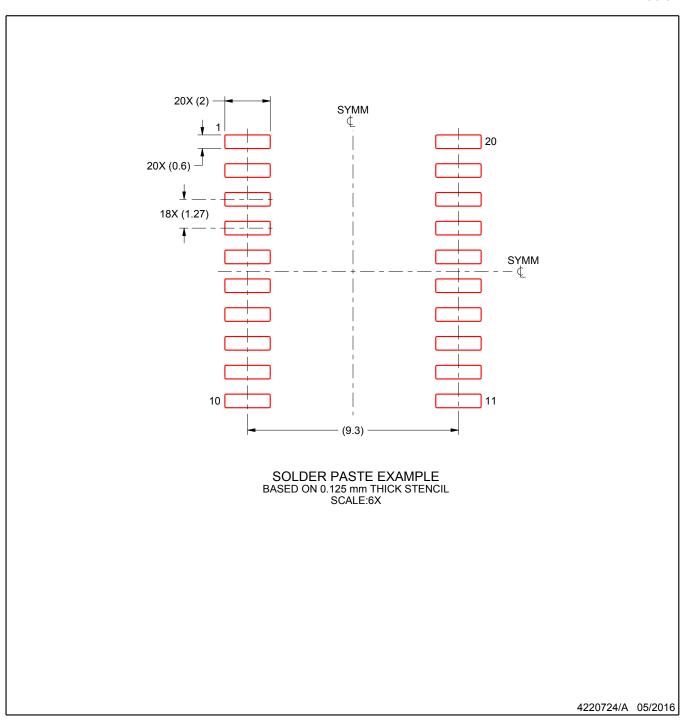


NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

SOIC

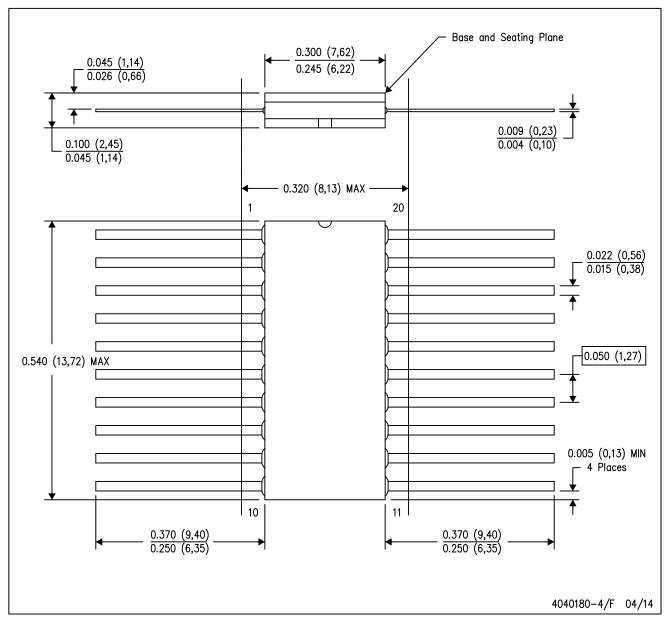


NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.

W (R-GDFP-F20)

CERAMIC DUAL FLATPACK



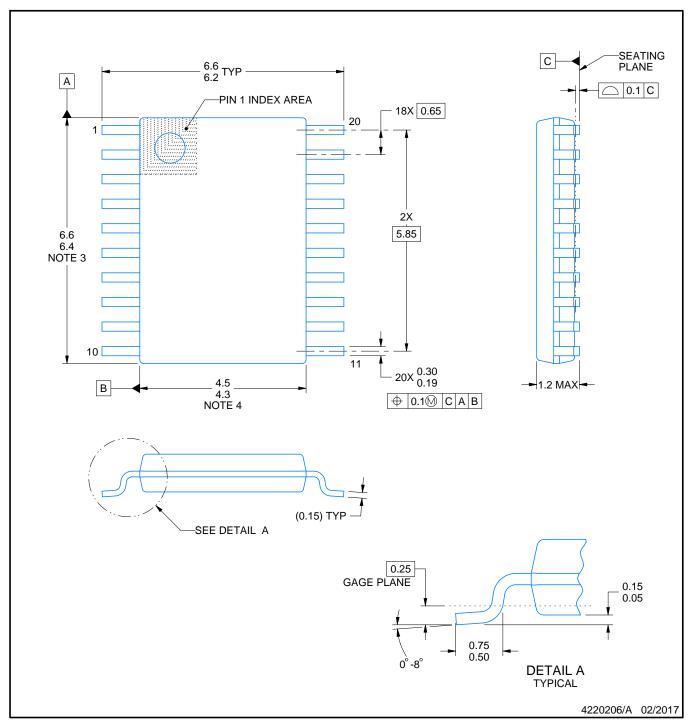
NOTES:

- A. All linear dimensions are in inches (millimeters).
- This drawing is subject to change without notice.
- This package can be hermetically sealed with a ceramic lid using glass frit. Index point is provided on cap for terminal identification only. Falls within Mil—Std 1835 GDFP2—F20 C.



TSSOP - 1.2 mm max height

SMALL OUTLINE PACKAGE



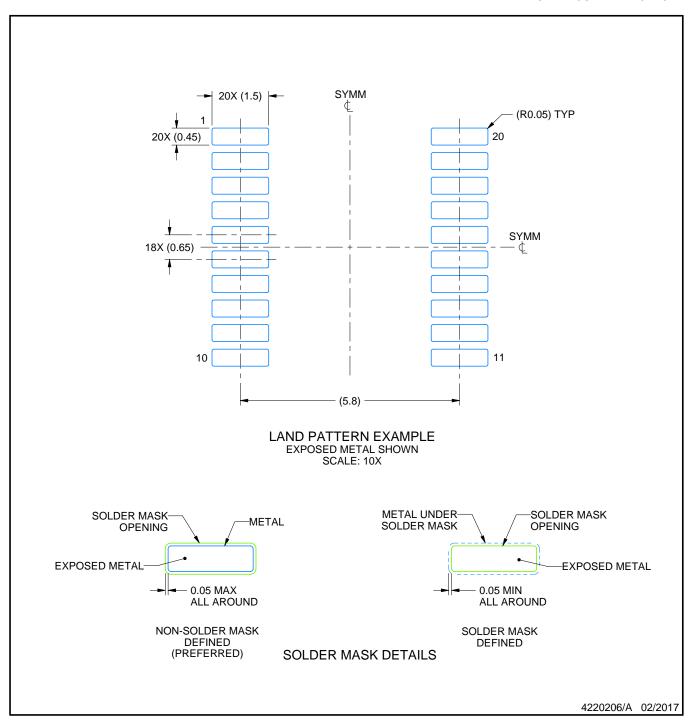
NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.

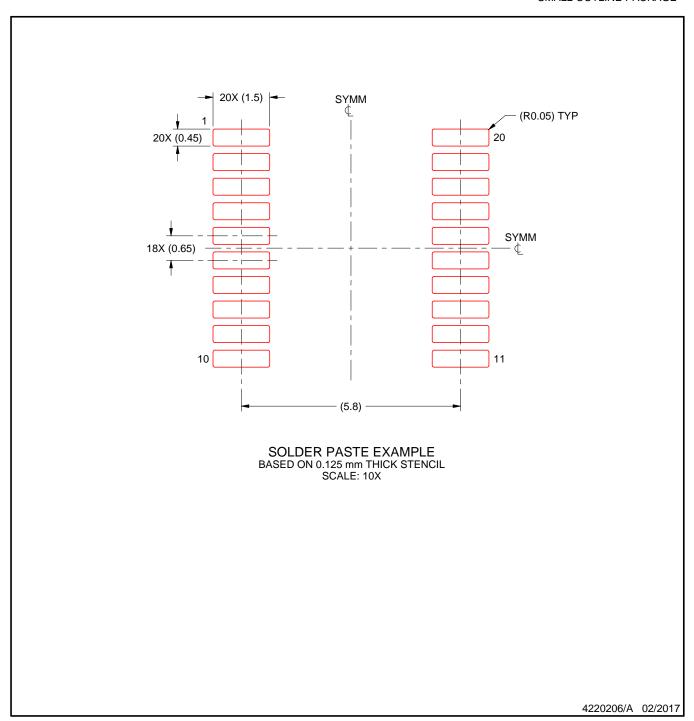




NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.

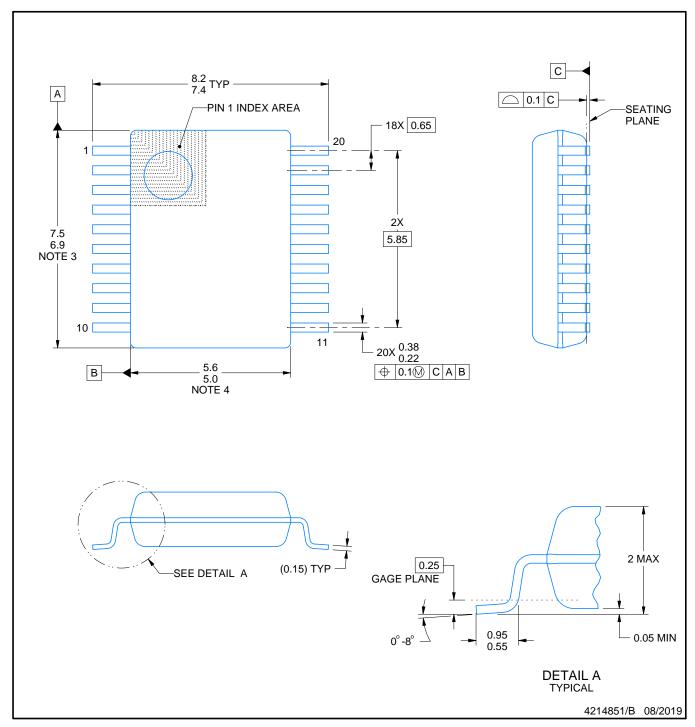


NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.







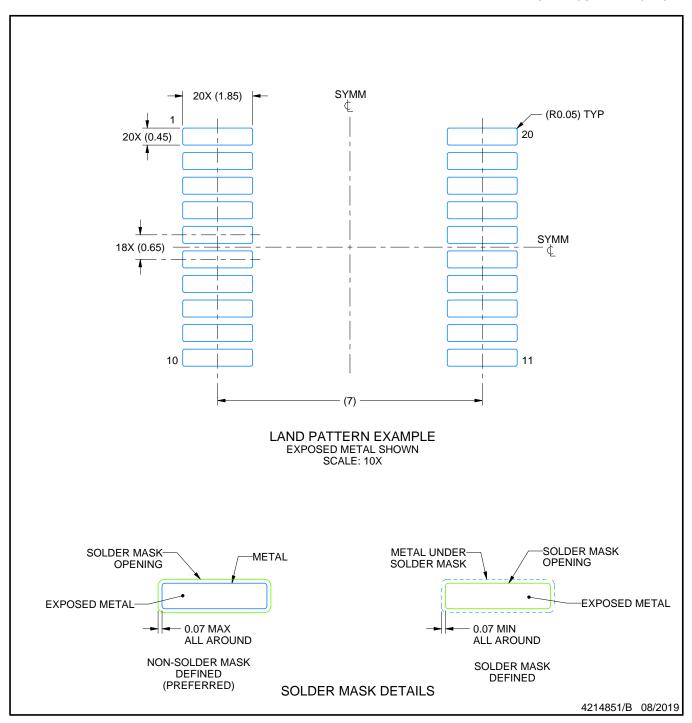
NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

 2. This drawing is subject to change without notice.

 3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-150.

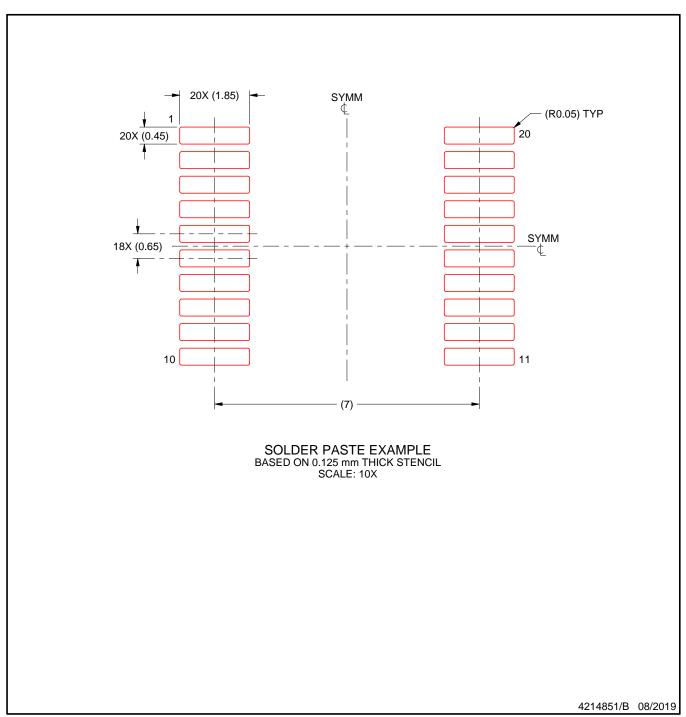




NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.

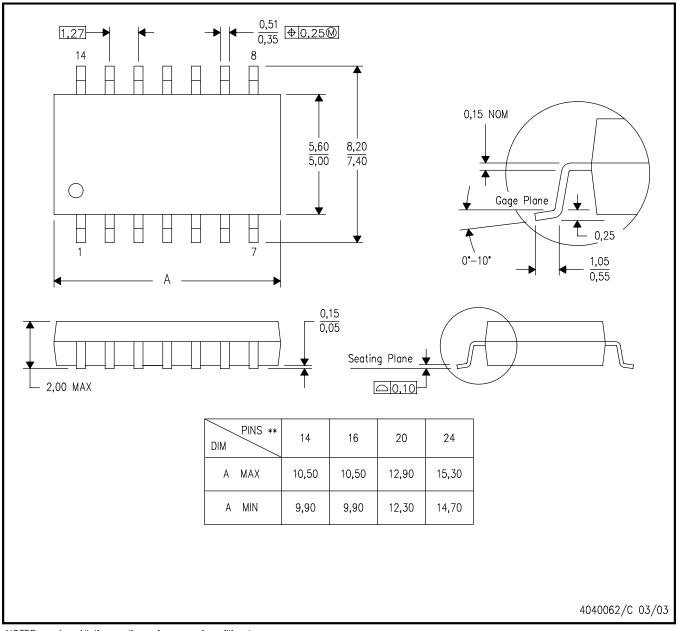


MECHANICAL DATA

NS (R-PDSO-G**)

14-PINS SHOWN

PLASTIC SMALL-OUTLINE PACKAGE



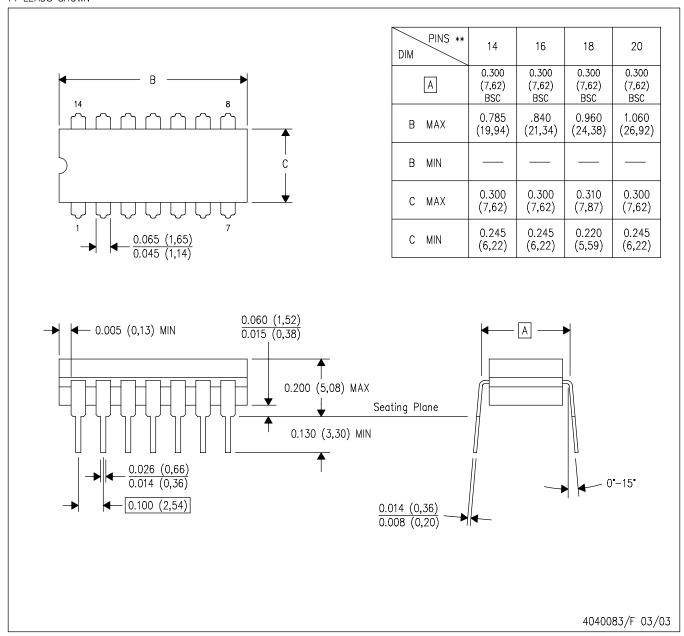
NOTES:

- All linear dimensions are in millimeters.
- B. This drawing is subject to change without notice.
- C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15.



J (R-GDIP-T**)

14 LEADS SHOWN



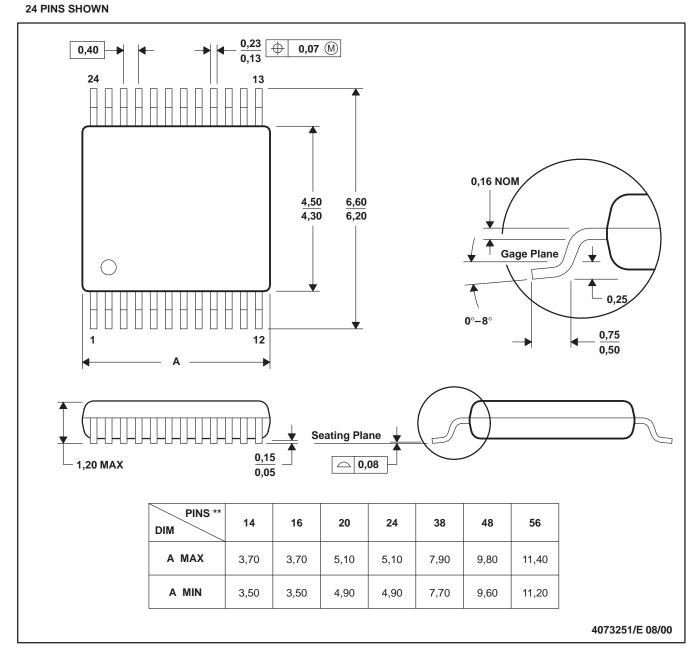
NOTES:

- A. All linear dimensions are in inches (millimeters).
- B. This drawing is subject to change without notice.
- C. This package is hermetically sealed with a ceramic lid using glass frit.
- D. Index point is provided on cap for terminal identification only on press ceramic glass frit seal only.
- E. Falls within MIL STD 1835 GDIP1-T14, GDIP1-T16, GDIP1-T18 and GDIP1-T20.

DGV (R-PDSO-G**)

•

PLASTIC SMALL-OUTLINE



NOTES: A. All linear dimensions are in millimeters.

B. This drawing is subject to change without notice.

C. Body dimensions do not include mold flash or protrusion, not to exceed 0,15 per side.

D. Falls within JEDEC: 24/48 Pins – MO-153

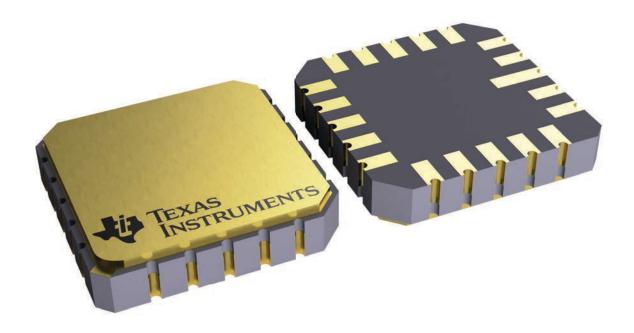
14/16/20/56 Pins - MO-194



8.89 x 8.89, 1.27 mm pitch

LEADLESS CERAMIC CHIP CARRIER

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.





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